## Notice of References Cited Application/Control No. 10/696,417 Examiner Kevin M. Picardat U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination YEO ET AL. Art Unit 2822 Page 1 of 1 U.S. PATENT DOCUMENTS Name Classification

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,596,599	07-2003	Guo, Jyh-Chyurn	438/305
	В	US-6,803,624	10-2004	Rudeck et al.	257/315
	С	US-6,716,689	04-2004	Bae et al.	438/182
	D	US-5,786,254	07-1998	Hao et al.	438/287
	E	US-5,990,532	11-1999	Gardner, Mark I.	257/410
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	a					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	v							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.